Power MOSFET

30 V, 210 A, Single N-Channel, SO-8 FL

Features

- Low R_{DS(on)} to Improve Conduction and Overall Efficiency
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- OR-ing FET, Power Load Switch, Motor Control
- Refer to Application Note AND8195/D for Mounting Information

End Products

• Server, UPS, Fault-Tolerant Power Systems, Hot Swap

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

	(-0 -			/	
Para	meter		Symbol	Value	Unit
Drain-to-Source Volta	age		V_{DSS}	30	V
Gate-to-Source Volta	ıge		V_{GS}	±20	V
Continuous Drain		T _A = 25°C	I _D	34	Α
Current R _{θJA} (Note 1)		T _A = 100°C		21.5	
Power Dissipation R _{θJA} (Note 1)		T _A = 25°C	P _D	2.74	W
Continuous Drain		T _A = 25°C	I _D	65	Α
Current R _{θJA} ≤ 10 s (Note 1)		T _A = 100°C		41	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T _A = 25°C	P _D	10.2	W
Continuous Drain	State	T _A = 25°C	I _D	20	Α
Current R _{θJA} (Note 2)		T _A = 100°C		12.5	
Power Dissipation R _{0JA} (Note 2)		T _A = 25°C	P _D	0.95	W
Continuous Drain		T _C = 25°C	I _D	210	Α
Current R _{θJC} (Note 1)		T _C =100°C		132	
Power Dissipation R _{0JC} (Note 1)		T _C = 25°C	P _D	104	W
Pulsed Drain Current	$T_A = 25^{\circ}$	°C, t _p = 10 μs	I _{DM}	400	Α
Operating Junction and Storage Temperature		T _J , T _{STG}	–55 to +150	°C	
Source Current (Body Diode)		I _S	95	Α	
Drain to Source DV/DT		dV/d _t	4.4	V/ns	
Single Pulse Drain-to-Source Avalanche Energy (T_J = 25°C, V_{DD} = 24 V, V_{GS} = 10 V, I_L = 58 A_{pk} , L = 0.3 mH, R_G = 25 Ω)		E _{AS}	504	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

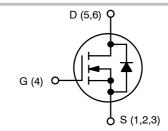
- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.



ON Semiconductor®

http://onsemi.com

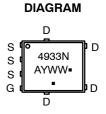
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	1.2 mΩ @ 10 V	210 A
30 V	2.0 mΩ @ 4.5 V	2107



N-CHANNEL MOSFET

SO-8 FLAT LEAD

CASE 488AA STYLE 1



MARKING

A = Assembly Location

Y = Year WW = Work Week • Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4933NT1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel
NTMFS4933NT3G	SO-8 FL (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	1.2	
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	45.7	°C/W
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	132	C/VV
Junction-to-Ambient - (t ≤ 10 s) (Note 3)	$R_{ heta JA}$	12.3	

FI FCTRICAL CHARACTERISTICS (T = 25°C unless otherwise specified)

Parameter	Symbol	Test Condi	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						1
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				15		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25°C			1.0	^
		v _{DS} = 24 v	T _J = 125°C			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±20 V				±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D$	= 250 μΑ	1.2	1.6	2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		0.9	1.2	- mΩ
			I _D = 15 A		0.9		
		V _{GS} = 4.5 V	I _D = 30 A		1.5	2.0	
			I _D = 15 A		1.5		
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _D = 15 A			82		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			10930		pF
Output Capacitance	Coss				3230		
Reverse Transfer Capacitance	C _{RSS}				92		
Total Gate Charge	Q _{G(TOT)}				62.1		
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 30 A			15.7		nC
Gate-to-Source Charge	Q_{GS}				27		
Gate-to-Drain Charge	Q_{GD}				10.1		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V; I _D = 30 A			148		nC
SWITCHING CHARACTERISTICS (Note 6)							-
Turn-On Delay Time	t _{d(ON)}				31		
Rise Time	t _r	V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			33		ns
Turn-Off Delay Time	t _{d(OFF)}				47		
Fall Time	t _f				23		

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

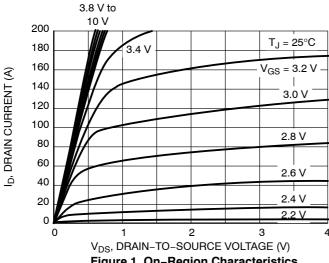
^{5.} Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.
6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 6)			•	•		
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			20		- ns
Rise Time	t _r				26		
Turn-Off Delay Time	t _{d(OFF)}				88.6		
Fall Time	t _f				22		
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 V,$ $I_{S} = 30 A$	T _J = 25°C		0.82	1.1	
			T _J = 125°C		0.68		V
Reverse Recovery Time	t _{RR}	V_{GS} = 0 V, dIS/dt = 100 A/ μ s, I_{S} = 30 A			73.5		ns
Charge Time	t _a				35.9		
Discharge Time	t _b				37.6		
Reverse Recovery Charge	Q _{RR}				117		nC
PACKAGE PARASITIC VALUES					-		
Source Inductance	L _S	T _A = 25°C			0.50		nΗ
Drain Inductance	L _D				0.005		nΗ
Gate Inductance	L _G				1.84		nΗ
Gate Resistance	R_{G}				1.1	2.2	Ω

^{5.} Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



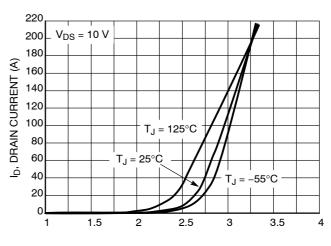
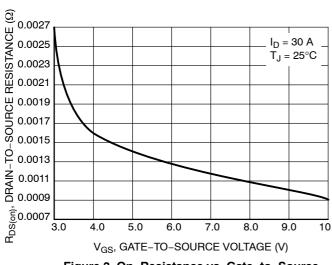


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



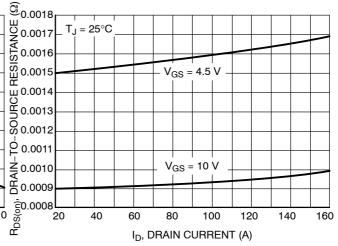
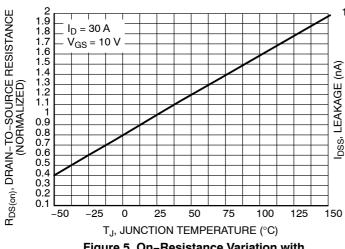
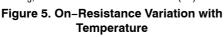


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and **Gate Voltage**





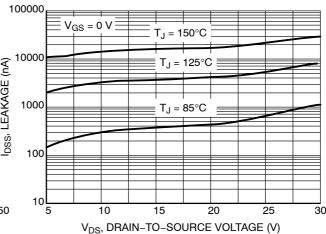
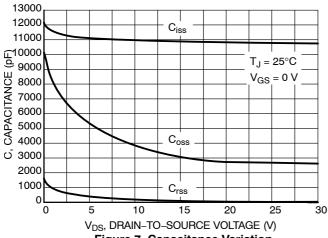


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

10

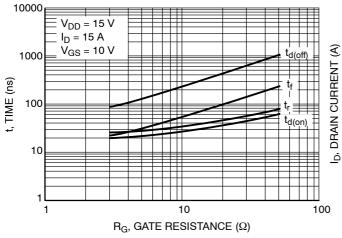
 $T_J = 25^{\circ}C$



V_{GS}, GATE-TO-SOURCE VOLTAGE (V) Q_T 6 5 4 QGS 3 Q_{GD} V_{DD} = 15 V 2 V_{GS} = 10 V $I_D = 30 A$ 20 60 80 100 QG, TOTAL GATE CHARGE (nC)

Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge



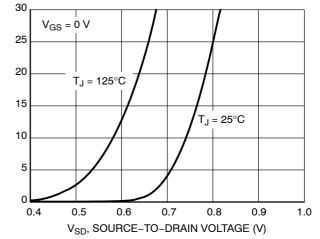
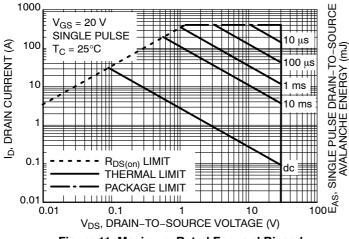


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current



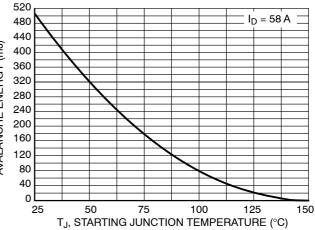


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Maximum Avalanche Energy vs. **Starting Junction Temperature**

TYPICAL CHARACTERISTICS

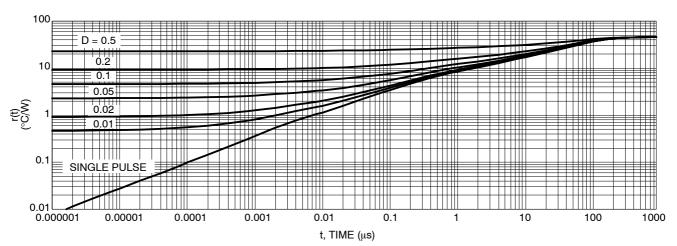


Figure 13. Thermal Response

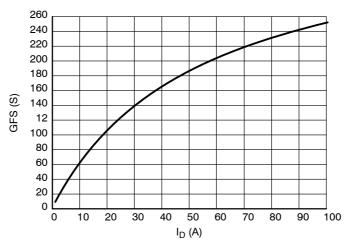
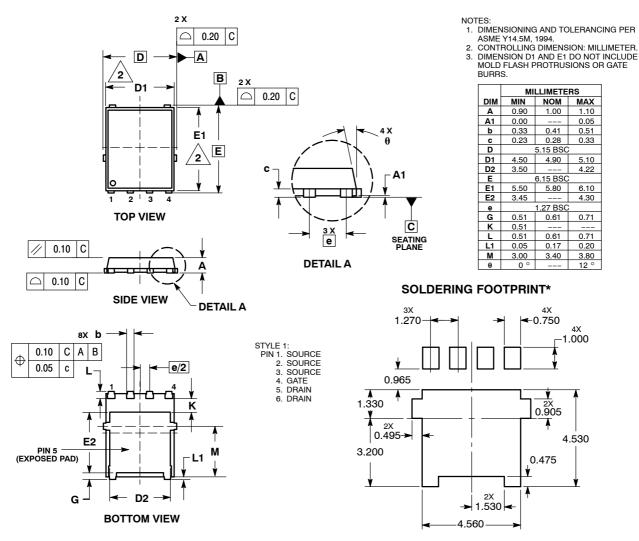


Figure 14. GFS vs. I_D

PACKAGE DIMENSIONS

DFN5 5x6, 1.27P (SO8 FL)CASE 488AA-01 ISSUE D



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and are registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA **Phone**: 303–675–2175 or 800–344–3860 Toll Free USA/Canada

Fax: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800-282-9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910 Japan Customer Focus Center

Phone: 81-3-5773-3850

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative